

Search Notes

Application/Control No.

10/808,626

Examiner

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Applicant(s)/Patent under
Reexamination

NAKAMURA, AKIHIRO

Art Unit

2854

SEARCHED

Class	Subclass	Date	Examiner
search updated		2/28/06	R.Y.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR